# SONY

# ICX415AL

Diagonal 8mm (Type 1/2) Progressive Scan CCD Solid-state Image Sensor with Square Pixel for CCIR B/W Cameras

#### Description

The ICX415AL is a diagonal 8mm (Type 1/2) interline CCD solid-state image sensor with a square pixel array suitable for CCIR black-and-white cameras. Progressive scan allows all pixel's signals to be output independently within approximately 1/50 second. This chip features an electronic shutter with variable charge-storage time which makes it possible to realize full-frame still images without a mechanical shutter. Square pixel makes this device suitable for image input and processing applications. High sensitivity and low dark current are achieved through the adoption of the HAD (Hole-Accumulation Diode) sensors.

This chip is suitable for applications such as FA and surveillance cameras.



- Progressive scan allows individual readout of the image signals
- High vertical resolution (580 TV-lines) still images without a mechanical shutter
- Square pixel
- Horizontal drive frequency: 29.5MHz (Max.)
- No voltage adjustments (reset gate and substrate bias are not adjusted.)
- · High resolution, high sensitivity, low dark current
- Continuous variable-speed shutter
- · Low smear
- WW.DZSC.COM Excellent anti-blooming characteristics

#### **Device Structure**

- Interline CCD image sensor
- Diagonal 8mm (Type 1/2) Image size:
- Number of effective pixels: 782 (H) × 582 (V) approx. 460K pixels • Total number of pixels: 823 (H) × 592 (V) approx. 490K pixels

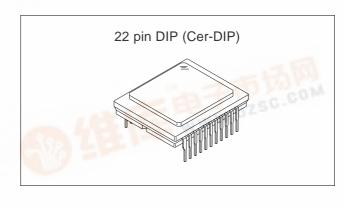
 Chip size: 7.48mm (H)  $\times$  6.15mm (V) • Unit cell size:  $8.3\mu m (H) \times 8.3\mu m (V)$ 

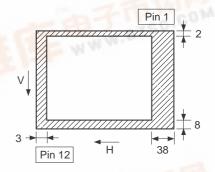
Horizontal (H) direction: Front 3 pixels, rear 38 pixels Optical black: Vertical (V) direction: Front 8 pixels, rear 2 pixels

Horizontal 19 Number of dummy bits:

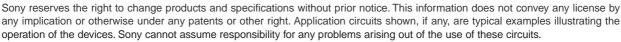
Vertical 5

 Substrate material: Silicon





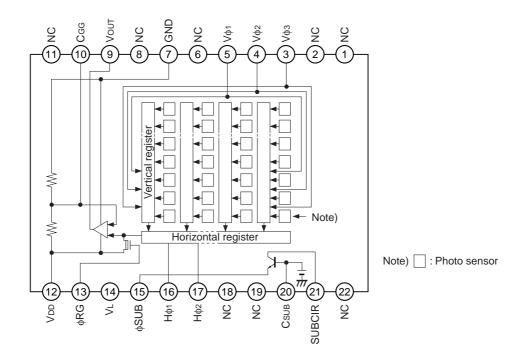
Optical black position (Top View)





# **Block Diagram and Pin Configuration**

(Top View)



# **Pin Description**

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	NC		12	Vdd	Supply voltage
2	NC		13	φRG	Reset gate clock
3	Vфз	Vertical register transfer clock	14	VL	Protective transistor bias
4	Vф2	Vertical register transfer clock	15	φSUB	Substrate clock
5	Vф1	Vertical register transfer clock	16	Нф1	Horizontal register transfer clock
6	NC		17	Нф2	Horizontal register transfer clock
7	GND	GND	18	NC	
8	NC		19	NC	
9	Vouт	Signal output	20	Csub	Substrate bias*2
10	Cgg	Output amplifier gate*1	21	SUBCIR	Supply voltage for the substrate voltage generation
11	NC		22	NC	

<sup>\*1</sup> DC bias is applied within the CCD, so that this pin should be grounded externally through a capacitance of 1µF or more.

<sup>\*2</sup> DC bias is applied within the CCD, so that this pin should be grounded externally through a capacitance of 0.1µF or more.

# **Absolute Maximum Ratings**

	Item	Ratings	Unit	Remarks
Substrate clock	B – GND	-0.3 to +55	V	
Supply voltage	VDD, VOUT, CGG, SUBCIR – GND	-0.3 to +18	V	
Cappiy rollage	Vdd, Vout, Cgg, SUBCIR – фSUB	-55 to +10	V	
Clock input voltage	Vφ1, Vφ2, Vφ3 – GND	-15 to +20	V	
l cross in part remage	Vφ1, Vφ2, Vφ3 – φSUB	to +10	V	
Voltage difference be	tween vertical clock input pins	to +15	V	*1
Voltage difference be	tween horizongal clock input pins	to +17	V	
Hφ1, Hφ2 – Vφ3		-16 to +16	V	
Hφ1, Hφ2 – GND		-10 to +15	V	
Hφ1, Hφ2 – φSUB		-55 to +10	V	
VL – ¢SUB		-65 to +0.3	V	
Vφ2, Vφ3 – VL		-0.3 to +27.5	V	
RG – GND		-0.3 to +22.5	V	
Vφ1, Hφ1, Hφ2, GND -	- VL	-0.3 to +17.5	V	
Storage temperature		-30 to +80	°C	
Performance guarant	ee temperature	-10 to +60	°C	
Operating temperatur	re	-10 to +75	°C	

 $<sup>^{*1}</sup>$  +27V (Max.) when clock width < 10 $\mu$ s, clock duty factor < 0.1%.

<sup>+16</sup>V (Max.) is guaranteed for power-on and power-off.

#### **Bias Conditions**

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Supply voltage	VDD	14.55	15.0	15.45	V	
Protective transistor bias	VL		*1	•		
Substrate clock	φSUB		*2			
Reset gate clock	φRG		*3			

<sup>\*1</sup> VL setting is the VvL voltage of the vertical transfer clock waveform, or the same voltage as the VL power supply for the V driver should be used.

Set SUBCIR pin to open when applying a DC bias the substrate clock pin.

Adjust the substrate voltage because the setting value of the substrate voltage is indicated on the back of image sensor by a special code when applying a DC bias the substrate clock pin.

$$\begin{tabular}{ll} Vsub code - two characters indication & $\square$ & $\square$ \\ & $\uparrow$ & $\uparrow$ \\ \hline & Integer portion & Decimal portion \\ \end{tabular}$$

The integer portion of the code and the actual value correspond to each other as follows.

Integer portion of code	Α	С	d	Е	f	G	h	J
Value	5	6	7	8	9	10	11	12

[Example] "A5"  $\rightarrow$  Vsub = 5.5V

#### **DC Characteristics**

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Supply current	IDD	4.0	7.0	9.0	mA	

<sup>\*2</sup> Indications of substrate voltage setting value

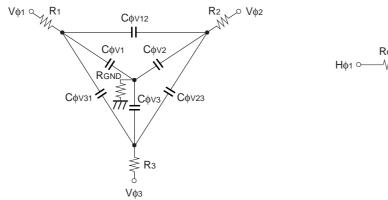
<sup>\*3</sup> Do not apply a DC bias to the reset gate clock pins, because a DC bias is generated within the CCD.

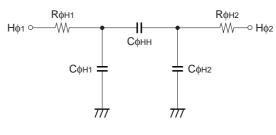
# **Clock Voltage Conditions**

Item	Symbol	Min.	Тур.	Max.	Unit	Waveform Diagram	Remarks
Readout clock voltage	Vvт	14.55	15.0	15.45	V	1	
	VvH02	-0.05	0	0.05	V	2	VvH = VvH02
	Vvh1, Vvh2, Vvh3	-0.2	0	0.05	V	2	
	VVL1, VVL2, VVL3	-7.8	-7.5	-7.2	V	2	$V_{VL} = (V_{VL1} + V_{VL3})/2$ (During 29.5MHz)
Vertical transfer clock	VVL1, VVL2, VVL3	-8.0	-7.5	-7.0	V	2	$V_{VL} = (V_{VL1} + V_{VL3})/2$ (During 14.75MHz)
voltage	Vф1, Vф2, Vф3	6.8	7.5	8.05	V	2	
	VVL1 — VVL3			0.1	V	2	
	Vvнн			0.5	V	2	High-level coupling
	Vvhl			0.5	V	2	High-level coupling
	Vvlh			0.5	V	2	Low-level coupling
	VVLL			0.5	V	2	Low-level coupling
	Vфн	4.75	5.0	5.25	V	3	
Horizontal transfer clock voltage	VHL	-0.05	0	0.05	V	3	
olook voltago	Vcr	0.8	2.5		V	3	Cross-point voltage
	V¢RG	4.5	5.0	5.5	V	4	
Reset gate clock voltage	Vrglh – Vrgll			0.8	V	4	Low-level coupling
1011490	VRGL - VRGLm			0.5	V	4	Low-level coupling
Substrate clock voltage	Vфsuв	21.5	22.5	23.5	V	5	

# **Clock Equivalent Circuit Constants**

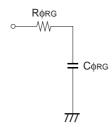
Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
	Сф∨1		3900		pF	
Capacitance between vertical transfer clock and GND	Сф∨2		3300		pF	
	Сф∨з		3300		pF	
	СфV12		2200		pF	
Capacitance between vertical transfer clocks	Сф∨23		2200		pF	
	Сф/31		1800		pF	
Capacitance between horizontal transfer clock and GND	Сфн1, Сфн2		47		pF	
Capacitance between horizontal transfer clocks	Сфнн		30		pF	
Capacitance between reset gate clock and GND	Сфяс		6		pF	
Capacitance between substrate clock and GND	Сфѕив		390		pF	
Vertical transfer alsolves resistan	R1, R2		27		Ω	
Vertical transfer clock series resistor	R <sub>3</sub>		22		Ω	
Vertical transfer clock ground resistor	RGND		100		Ω	
Horizontal transfer clock series resistor	Rфн1, Rфн2		16		Ω	
Reset gate clock series resistor	Rørg		36		Ω	





Vertical transfer clock equivalent circuit

Horizontal transfer clock equivalent circuit

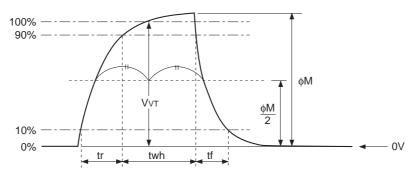


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#### **Drive Clock Waveform Conditions**

# (1) Readout clock waveform

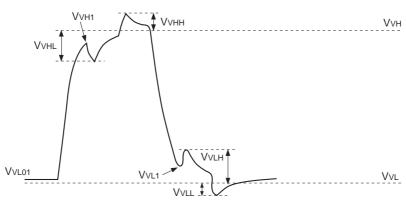
Vт



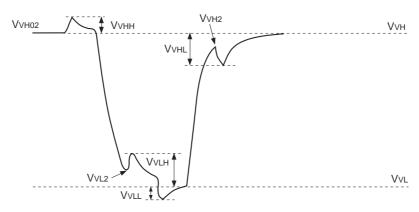
Note) Readout clock is used by composing vertical transfer clocks  $V\phi_2$  and  $V\phi_3$ .

# (2) Vertical transfer clock waveform

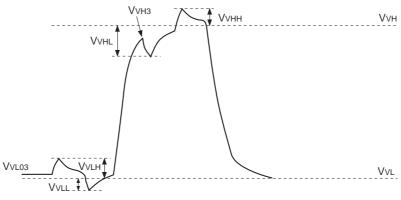
V<sub>\$\psi\$1</sub>



Vф2



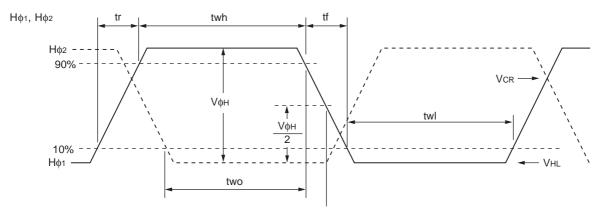
Vфз



-7-

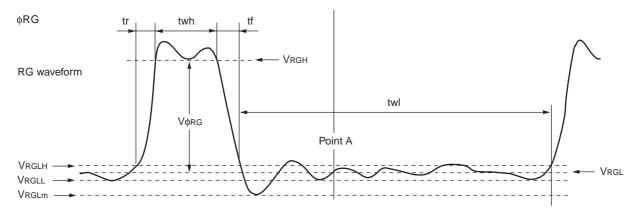
 $V\phi V1 = VVH1 - VVL01$   $V\phi V2 = VVH02 - VVL2$  $V\phi V3 = VVH3 - VVL03$ 

## (3) Horizontal transfer clock waveform



Cross-point voltage for the H $\phi$ 1 rising side of the horizontal transfer clocks H $\phi$ 1 and H $\phi$ 2 waveforms is Vcr. The overlap period for twh and twl of horizontal transfer clocks H $\phi$ 1 and H $\phi$ 2 is two.

# (4) Reset gate clock waveform



VRGLH is the maximum value and VRGLL is the minimum value of the coupling waveform during the period from Point A in the above diagram until the rising edge of RG.

In addition, VRGL is the average value of VRGLH and VRGLL.

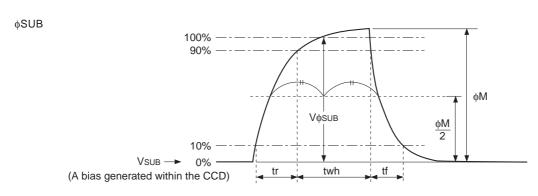
$$V_{RGL} = (V_{RGLH} + V_{RGLL})/2$$

Assuming VRGH is the minimum value during the interval twh, then:

$$V \phi RG = V RGH - V RGL$$

Negative overshoot level during the falling edge of RG is VRGLm.

# (5) Substrate clock waveform



# Clock Switching Characteristics (Horizontal drive frequency: 29.5MHz)

lt a sa	O. made al		twh			twl			tr			tf		l lmit	Damada
Item	Symbol	Min.	Тур.	Мах.	Unit	Remarks									
Readout clock	VT	2.3	2.5						0.5			0.5		μs	During readout
Vertical transfer clock	Vφ1, Vφ2, Vφ3										15		250	ns	When using CXD3400N
Horizontal	Нф1	9.5	12.0		9.5	12.0			5.0	7.5		5.0	7.5	20	46 > 411 - 0110
transfer clock	Нф2	9.5	12.0		9.5	12.0			5.0	7.5		5.0	7.5	ns	tf ≥ tr – 2ns
Reset gate clock	φRG	4	7			22			2			3		ns	
Substrate clock	φSUB	0.7	0.8							0.5			0.5	μs	When draining charge

Item	Symbol		two		Unit	Domorko	
item	Symbol	Min.	Тур.	Мах.	Offic	Remarks	
Horizontal transfer clock	<b>Н</b> ф1, <b>Н</b> ф2	7.5	9.5		ns	*1	

# Clock Switching Characteristics (Horizontal drive frequency: 14.75MHz)

			twh			twl			tr			tf		1.1	Demonto	
Item	Symbol	Min.	Тур.	Мах.	Unit	Remarks										
Readout clock	VT	4.6	5.0						0.5			0.5		μs	During readout	
Vertical transfer clock	Vφ1, Vφ2, Vφ3										15		350	ns	When using CXD3400N	
Horizontal	Нф1	18	23		21	26			10	17.5		10	17.5		# > + = O = =	
transfer clock	Нф2	21	26		18	23			10	15		10	15	ns	tf ≥ tr – 2ns	
Reset gate clock	φRG	11	14			49			2			2		ns		
Substrate clock	φSUB	1.4	1.6							0.4			0.4	μs	When draining charge	

Itom	Cumbal		two		Lloit	Domorko	
Item	Symbol	Min.	Тур.	Мах.	Unit	Remarks	
Horizontal transfer clock	<b>Н</b> ф1, <b>Н</b> ф2	20	24		ns	*1	

<sup>\*1</sup> The overlap period of twh and twl of horizontal transfer clocks  $H\phi_1$  and  $H\phi_2$  is two.

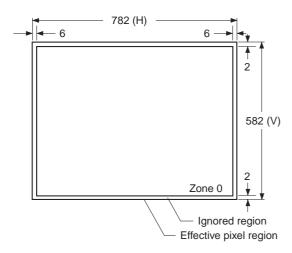
# **Image Sensor Characteristics**

 $(Ta = 25^{\circ}C)$ 

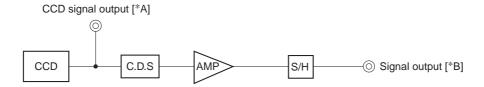
Item	Symbol	Min.	Тур.	Max.	Unit	Measurement method	Remarks
Sensitivity	S	650	820	1070	mV	1	1/25s accumulation conversion value
Saturation signal	Vsat	375			mV	2	Ta = 60°C
Smear	Sm		-100	-92	dB	3	
Video signal shading	SH			25	%	4	Zone 0
Dark signal	Vdt			2	mV	5	Ta = 60°C
Dark signal shading	ΔVdt			1	mV	6	Ta = 60°C
Lag	Lag			0.5	%	7	

Note) All image sensor characteristic data noted above is for operation in 1/50s progressive scan mode.

# **Zone Definition of Video Signal Shading**



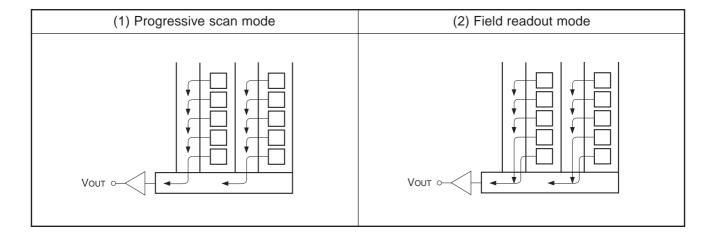
# **Measurement System**



Note) Adjust the amplifier gain so that the gain between [\*A] and [\*B] equals 1.

#### Image sensor readout mode

The diagram below shows the output methods for the following three readout modes.



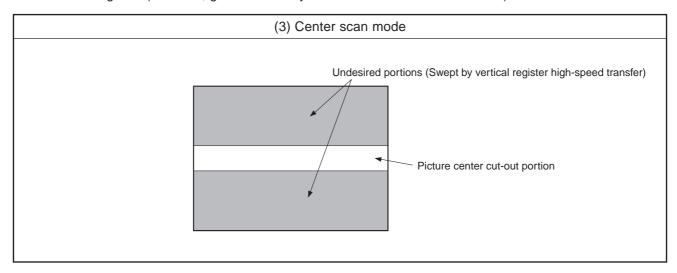
#### 1. Progressive scan mode

In this mode, all pixel signals are output in non-interlace format in 1/50s.

All pixel signals within the same exposure period are read out simultaneously, making this mode suitable for high resolution image capturing.

#### 2. Field readout mode

All pixels are readout, 2-line transfer is performed during H blanking period and 2 pixels are added by horizontal register. (However, guarantees only at the time of a 14.75MHz drive.)



#### 3. Center scan mode

This is the center scan mode using the progressive scan method.

The undesired portions are swept by vertical register high-speed transfer, and the picture center portion is cut out.

There are the mode (100 frames/s) which outputs 264 lines of an output line portion, and the mode (200 frames/s) which outputs 88 lines.

## **Image Sensor Characteristics Measurement Method**

#### Measurement conditions

(1) In the following measurements, the substrate voltage is set to the value indicated on the device, and the device drive conditions are at the typical values of the bias and clock voltage conditions.

- (2) In the following measurements, spot blemishes are excluded and, unless otherwise specified, the optical black level (OB) is used as the reference for the signal output, which is taken as the value measured at point [\*B] of the measurement system.
- (3) In the following measurements, this image sensor is operated in 1/50s progressive scan mode.

#### O Definition of standard imaging conditions

## (1) Standard imaging condition I:

Use a pattern box (luminance: 706cd/m², color temperature of 3200K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F8. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

#### (2) Standard imaging condition II:

Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

#### 1. Sensitivity

Set to standard imaging condition I. After setting the electronic shutter mode with a shutter speed of 1/250s, measure the signal voltage (Vs) at the center of the screen, and substitute the value into the following formula.

$$S = Vs \times \frac{250}{25} [mV]$$

#### 2. Saturation signal

Set to standard imaging condition II. After adjusting the luminous intensity to 10 times the intensity with the average value of the signal output, 120mV, measure the minimum value of the signal output.

#### 3. Smear

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, first adjust the luminous intensity to 500 times the intensity with the average value of signal output, 120mV. Then after the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value (VSm [mV]) of the signal output and substitute the value into the following formula.

Sm = 
$$20 \times log \left( \frac{VSm}{120} \times \frac{1}{500} \times \frac{1}{10} \right)$$
 [dB] (1/10V method conversion value)

# 4. Video signal shading

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity so that the average value of the signal output is 120mV. Then measure the maximum (Vmax [mV]) and minimum (Vmin [mV]) values of the signal output and substitute the values into the following formula.

$$SH = (Vmax - Vmin)/120 \times 100 [\%]$$

#### 5. Dark signal

Measure the average value of the signal output (Vdt [mV]) with the device ambient temperature 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as a reference.

# 6. Dark signal shading

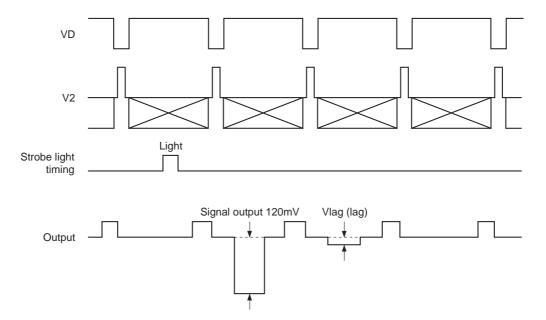
After measuring 5, measure the maximum (Vdmax [mV]) and minimum (Vdmin [mV]) values of the dark signal output and substitute the values into the following formula.

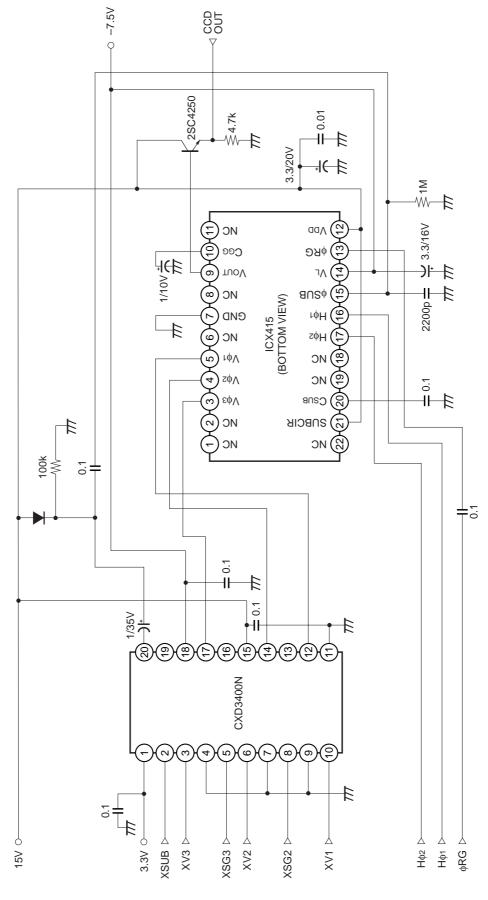
 $\Delta Vdt = Vdmax - Vdmin [mV]$ 

# 7. Lag

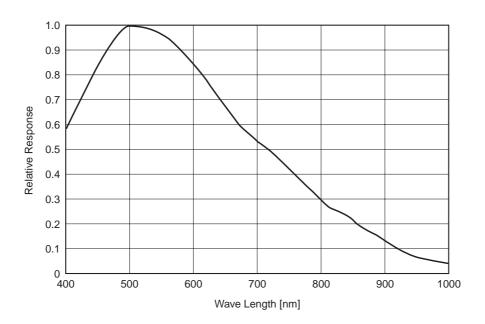
Adjust the signal output generated by strobe light to 120mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal (Vlag). Substitute the value into the following formula.

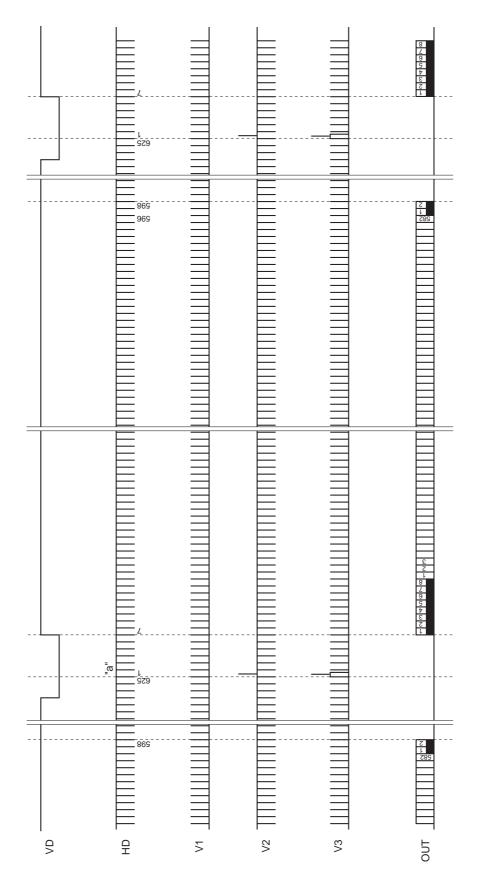
 $Lag = (Vlag/120) \times 100 [\%]$ 



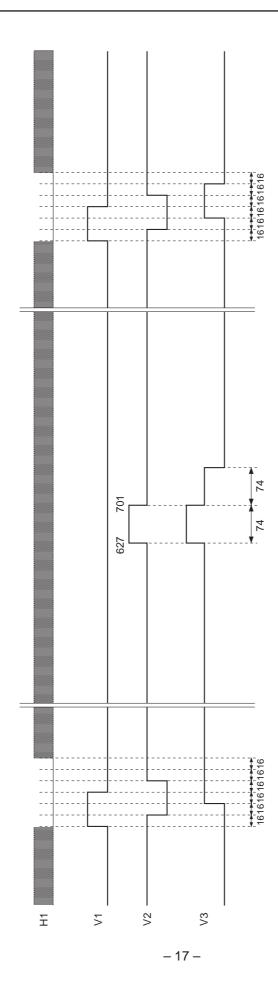


Spectral Sensitivity Characteristics (Excludes lens characteristics and light source characteristics)

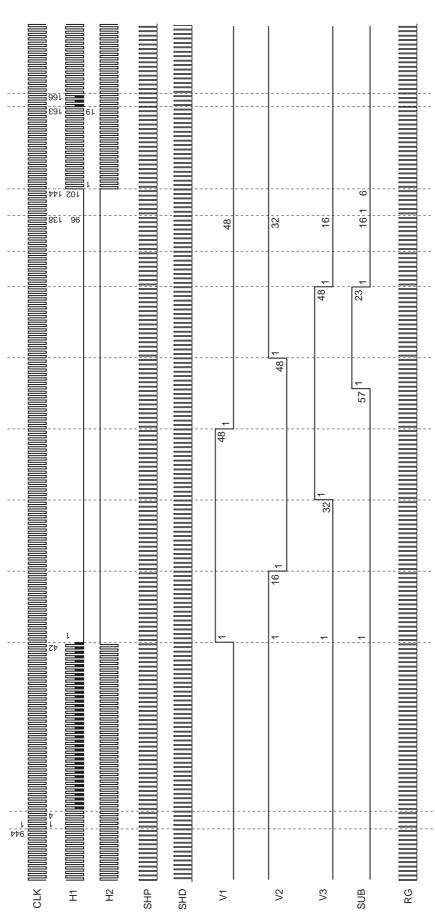


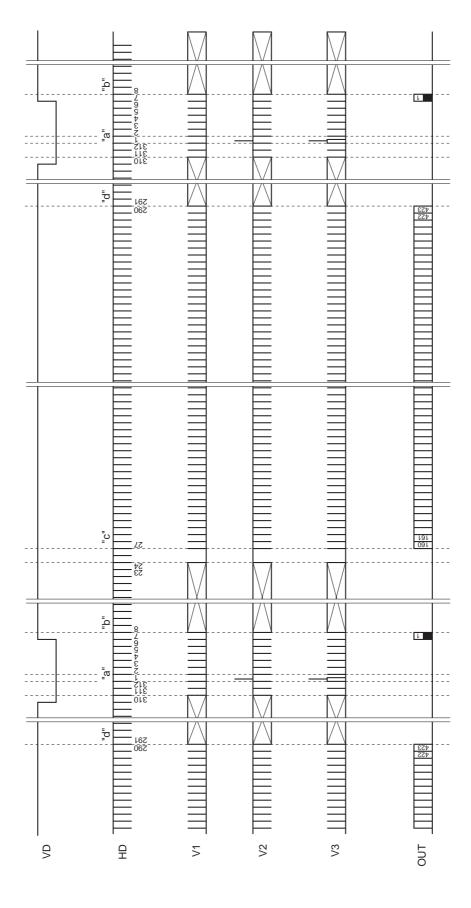


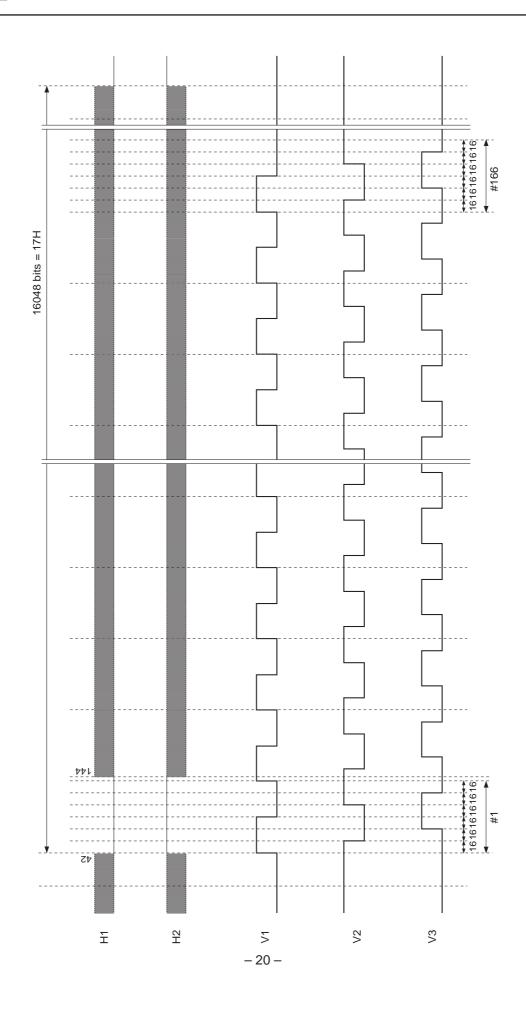
Progressive Scan Mode/Center Scand Mode Drive Timing Chart (Vertical Sync "a" Enlarged)

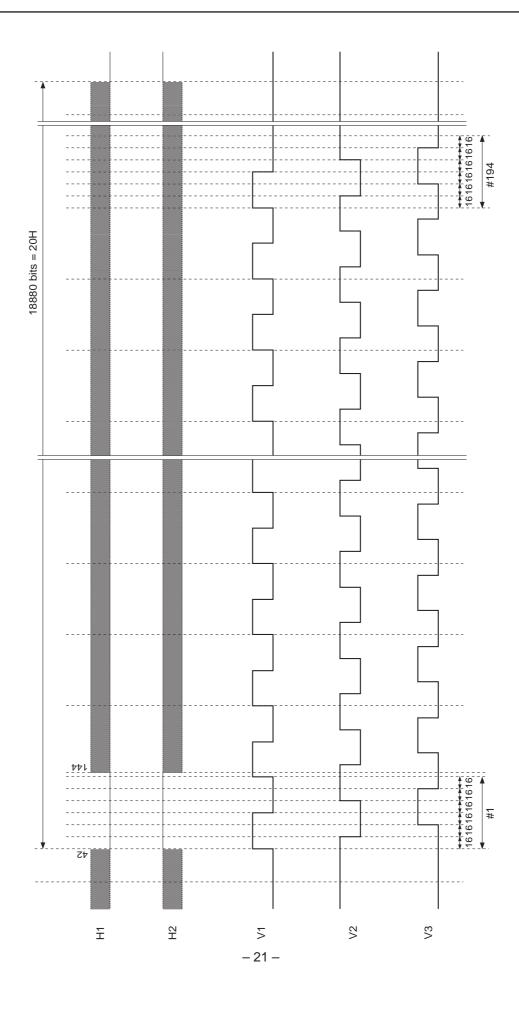


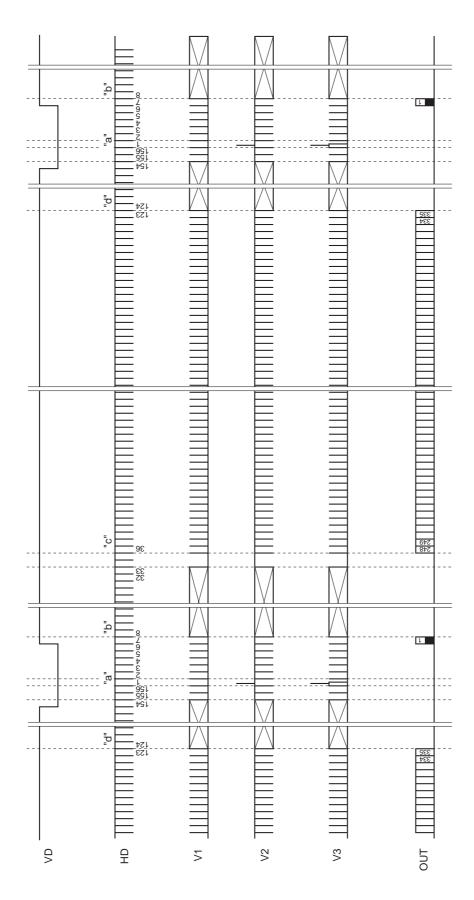


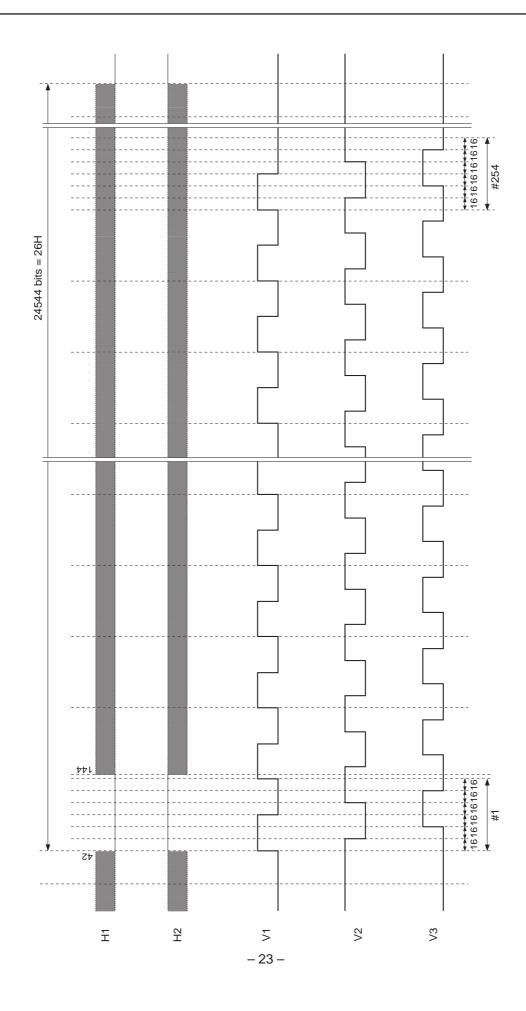


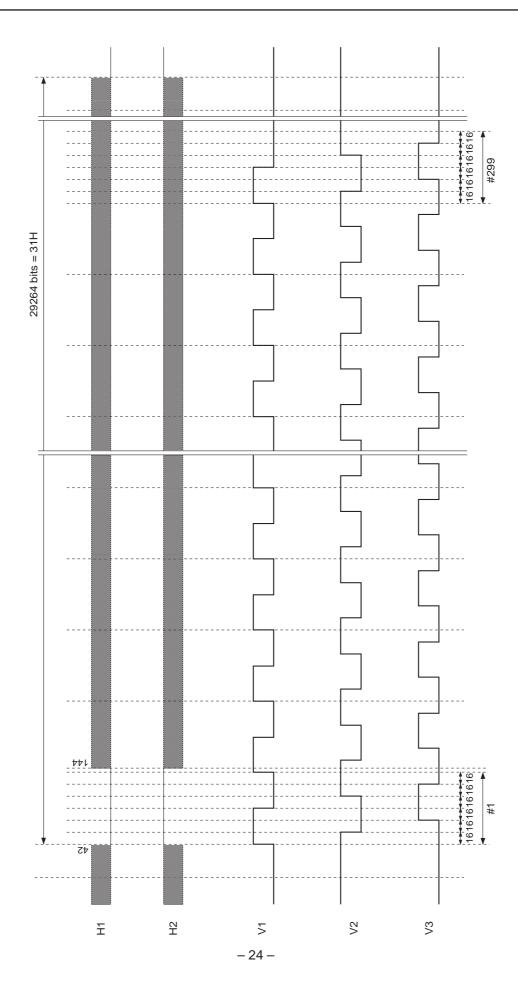




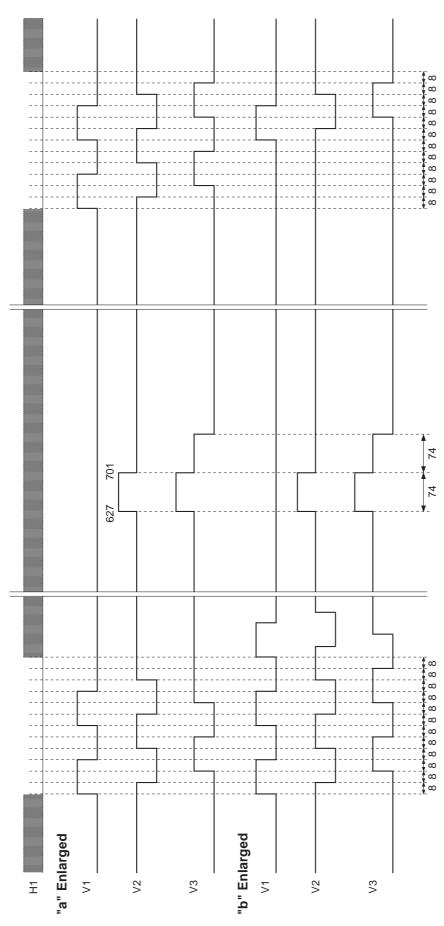




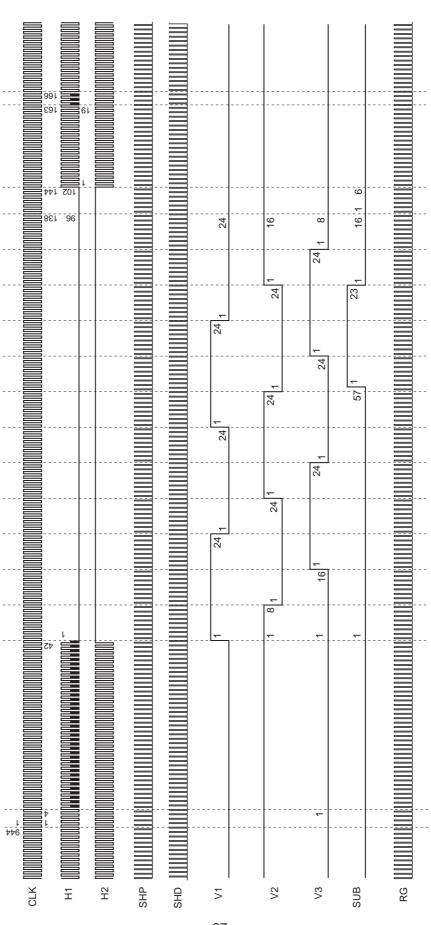












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#### **Notes on Handling**

#### 1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

- a) Either handle bare handed or use non-chargeable gloves, clothes or material. Also use conductive shoes.
- b) When handling directly use an earth band.
- c) Install a conductive mat on the floor or working table to prevent the generation of static electricity.
- d) Ionized air is recommended for discharge when handling CCD image sensor.
- e) For the shipment of mounted substrates, use boxes treated for the prevention of static charges.

#### 2) Soldering

- a) Make sure the package temperature does not exceed 80°C.
- b) Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a 30W soldering iron with a ground wire and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
- c) To dismount an image sensor, do not use a solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero cross On/Off type and connect it to ground.

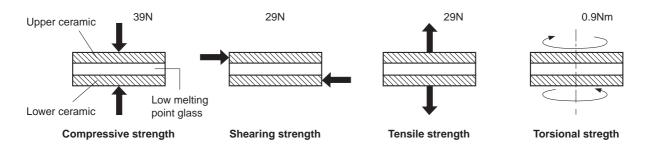
#### 3) Dust and dirt protection

Image sensors are packed and delivered by taking care of protecting its glass plates from harmful dust and dirt. Clean glass plates with the following operation as required, and use them.

- a) Perform all assembly operations in a clean room (class 1000 or less).
- b) Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface, blow it off with an air blower. (For dirt stuck through static electricity ionized air is recommended.)
- c) Clean with a cotton bud and ethyl alcohol if the grease stained. Be careful not to scratch the glass.
- d) Keep in a case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- e) When a protective tape is applied before shipping, just before use remove the tape applied for electrostatic protection. Do not reuse the tape.

#### 4) Installing (attaching)

a) Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)



b) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the ceramic portions. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

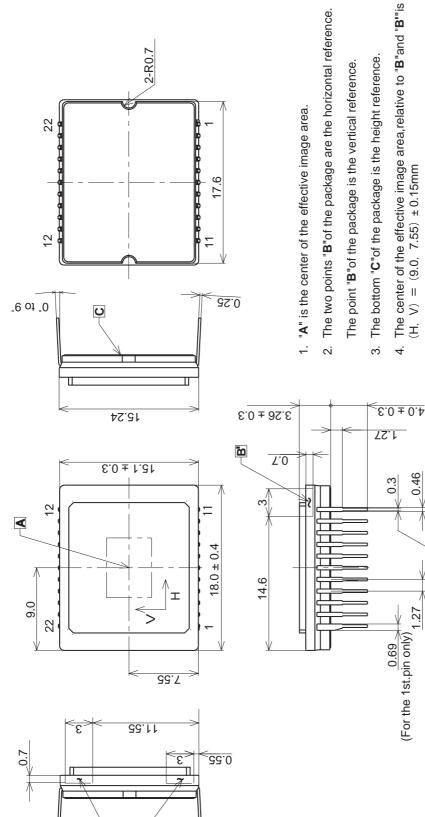
- c) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to other locations as a precaution.
- d) The notch of the package is used for directional index, and that can not be used for reference of fixing. In addition, the cover glass and seal resin may overlap with the notch of the package.
- e) If the leads are bent repeatedly and metal, etc., clash or rub against the package, the dust may be generated by the fragments of resin.
- f) Acrylate anaerobic adhesives are generally used to attach CCD image sensors. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives. (reference)

## 5) Others

- a) Do not expose to strong light (sun rays) for long periods. For continuous using under cruel condition exceeding the normal using condition, consult our company.
- b) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.
- c) Brown stains may be seen on the bottom or side of the package. But this does not affect the CCD characteristics.

Unit: mm Package Outline





The two points "B" of the package are the horizontal reference.

The rotation angle of the effective image area relative to H and V is  $\pm$  1 $^\circ$ 2

The height from bottom "C" to the effective image area is 1.41  $\pm$  0.15mm 9

 $(\Xi)$ 

0.3

 $\oplus$ 

The tilt of the effective image area relative to the bottom "C" is less than 60µm.

The thickness of the cover glass is 0.75mm, and the refractive index is 1.5. ω

The notches on the bottom must not be used for reference of fixing. 6

AS-B15-03(E)

**DRAWING NUMBER** 

2.60g

TIN PLATING

Cer-DIP

PACKAGE MATERIAL

LEAD TREATMENT LEAD MATERIAL PACKAGE MASS

42 ALLOY